

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
LOOK, CHRISTOPHER M.

Examiner

DANNY W. LEUNG

Art Unit

2613

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,076,163 B2	07-2006	Kinoshita et al.	398/19
*	B	US-6,504,969 B1	01-2003	Tsao et al.	385/24
*	C	US-5,515,361 A	05-1996	Li et al.	370/222
*	D	US-6,417,944 B1	07-2002	Lahat et al.	398/79
*	E	US-6,826,368 B1	11-2004	Koren et al.	398/50
*	F	US-6,369,926 B1	04-2002	Lyu et al.	398/95
*	G	US-5,708,753 A	01-1998	Frigo et al.	385/147
*	H	US-7,151,893 b2	12-2006	Hayashi et al.	398/7
*	I	US-7,035,537 b2	04-2006	Wang et al.	398/7
*	J	US-5,708,753 a	01-1998	Frigo et al.	385/147
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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